

DOCKET NO: 241160US2S



IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF :
YOSHINORI MATSUBARA : EXAMINER: CLARK, S. V.
SERIAL NO: 10/632,822 :
RCE FILED: HEREWITH : GROUP ART UNIT: 2823
FOR: SEMICONDUCTOR DEVICE, :
SEMICONDUCTOR DEVICE
MANUFACTURING METHOD,
AND SEMICONDUCTOR DEVICE
TEST METHOD

AMENDMENT FILED CONCURRENTLY WITH
REQUEST FOR CONTINUED EXAMINATION UNDER 37 C.F.R. § 1.114

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated February 16, 2006, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 6 of this paper.